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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details

Product Status	Discontinued at Digi-Key
Core Processor	F ² MC-16FX
Core Size	16-Bit
Speed	56MHz
Connectivity	CANbus, EBI/EMI, I ² C, LINbus, SCI, UART/USART
Peripherals	DMA, LVD, LVR, POR, PWM, WDT
Number of I/O	82
Program Memory Size	416KB (416K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 24x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/mb96f347asbpmc-gse2

Features

Feature	Description
Technology	<ul style="list-style-type: none"> ■ 0.18µm CMOS
CPU	<ul style="list-style-type: none"> ■ F²MC-16FX CPU ■ Up to 56 MHz internal, 17.8 ns instruction cycle time ■ Optimized instruction set for controller applications (bit, byte, word and long-word data types; 23 different addressing modes; barrel shift; variety of pointers) ■ 8-byte instruction execution queue ■ Signed multiply (16-bit × 16-bit) and divide (32-bit/16-bit) instructions available
System clock	<ul style="list-style-type: none"> ■ On-chip PLL clock multiplier (x1 - x25, x1 when PLL stop) ■ 3 MHz - 16 MHz external crystal oscillator clock (maximum frequency when using ceramic resonator depends on Q-factor). ■ Up to 56 MHz external clock for devices with fast clock input feature ■ 32-100 kHz subsystem quartz clock ■ 100kHz/2MHz internal RC clock for quick and safe startup, oscillator stop detection, watchdog ■ Clock source selectable from main- and subclock oscillator (part number suffix "W") and on-chip RC oscillator, independently for CPU and 2 clock domains of peripherals. ■ Low Power Consumption - 13 operating modes : (different Run, Sleep, Timer modes, Stop mode) ■ Clock modulator
On-chip voltage regulator	<ul style="list-style-type: none"> ■ Internal voltage regulator supports reduced internal MCU voltage, offering low EMI and low power consumption figures
Low voltage reset	<ul style="list-style-type: none"> ■ Reset is generated when supply voltage is below minimum.
Code Security	<ul style="list-style-type: none"> ■ Protects ROM content from unintended read-out
Memory Patch Function	<ul style="list-style-type: none"> ■ Replaces ROM content ■ Can also be used to implement embedded debug support
DMA	<ul style="list-style-type: none"> ■ Automatic transfer function independent of CPU, can be assigned freely to resources
Interrupts	<ul style="list-style-type: none"> ■ Fast Interrupt processing ■ 8 programmable priority levels ■ Non-Maskable Interrupt (NMI)
Timers	<ul style="list-style-type: none"> ■ Three independent clock timers (23-bit RC clock timer, 23-bit Main clock timer, 17-bit Sub clock timer) ■ Watchdog Timer
CAN	<ul style="list-style-type: none"> ■ Supports CAN protocol version 2.0 part A and B ■ ISO16845 certified ■ Bit rates up to 1 Mbit/s ■ 32 message objects ■ Each message object has its own identifier mask ■ Programmable FIFO mode (concatenation of message objects) ■ Maskable interrupt ■ Disabled Automatic Retransmission mode for Time Triggered CAN applications ■ Programmable loop-back mode for self-test operation
USART	<ul style="list-style-type: none"> ■ Full duplex USARTs (SCI/LIN) ■ Wide range of baud rate settings using a dedicated reload timer ■ Special synchronous options for adapting to different synchronous serial protocols ■ LIN functionality working either as master or slave LIN device

Feature	Description
Alarm comparator	<ul style="list-style-type: none"> ■ Monitors an external voltage and generates an interrupt in case of a voltage lower or higher than the defined thresholds ■ Threshold voltages defined externally or generated internally ■ Status is readable, interrupts can be masked separately
I/O Ports	<ul style="list-style-type: none"> ■ Virtually all external pins can be used as general purpose I/O ■ All push-pull outputs (except when used as I2C SDA/SCL line) ■ Bit-wise programmable as input/output or peripheral signal ■ Bit-wise programmable input enable ■ Bit-wise programmable input levels: Automotive / CMOS-Schmitt trigger / TTL (TTL levels not supported by all devices) ■ Bit-wise programmable pull-up resistor ■ Bit-wise programmable output driving strength for EMI optimization
Packages	<ul style="list-style-type: none"> ■ 100-pin plastic QFP and LQFP
Flash Memory	<ul style="list-style-type: none"> ■ Supports automatic programming, Embedded Algorithm ■ Write/Erase/Erase-Suspend/Resume commands ■ A flag indicating completion of the algorithm ■ Number of erase cycles: 10,000 times ■ Data retention time: 20 years ■ Erase can be performed on each sector individually ■ Sector protection ■ Flash Security feature to protect the content of the Flash ■ Low voltage detection during Flash erase

1. Product Lineup

Features		MB96V300B	MB96(F)34x	
Product type		Evaluation sample	Flash product: MB96F34x Mask ROM product: MB9634x	
Product options				
YS		NA	Low voltage reset persistently on / Single clock	
RS			Low voltage reset can be disabled / Single clock	
YW			Low voltage reset persistently on / Dual clock	
RW			Low voltage reset can be disabled / Dual clock	
TS			indep. 32KB Flash / Low voltage reset persistently on / Single clock	
HS			indep. 32KB Flash / Low voltage reset can be disabled / Single clock	
TW			indep. 32KB Flash / Low voltage reset persistently on / Dual clock	
HW			indep. 32KB Flash / Low voltage reset can be disabled / Dual clock	
FS			64KB Data Flash / Low voltage reset persistently on / Single clock	
DS			64KB Data Flash / Low voltage reset can be disabled / Single clock	
FW			64KB Data Flash / Low voltage reset persistently on / Dual clock	
DW			64KB Data Flash / Low voltage reset can be disabled / Dual clock	
AS			No CAN / Low voltage reset can be disabled / Single clock devices	
CS			No CAN / indep. 32KB Flash / Low voltage reset can be disabled / Single clock	
AW			No CAN / Low voltage reset can be disabled / Dual clock	
CW			No CAN / indep. 32KB Flash / Low voltage reset can be disabled / Dual clock	
Flash/ROM	RAM			
160KB	8KB	ROM/Flash memory emulation by external RAM, 92KB internal RAM	MB96345Y [1], MB96345R [1]	
224KB [Flash A: 160KB, Data Flash A: 64KB]	8KB		MB96F345F [1], MB96F345D [1]	
288KB	16KB		MB96F346Y, MB96346Y [1], MB96F346R, MB96346R [1], MB96F346A	
416KB	16KB		MB96F347Y, MB96F347R, MB96F347A	
544KB	24KB		MB96F348Y, MB96F348R, MB96F348A	
576KB [Flash A: 544KB, Flash B: 32KB]	24KB		MB96F348T, MB96F348H, MB96F348C	
Package		BGA416	FPT-100P-M20 FPT-100P-M22	
DMA		16 channels	6 channels	
USART		10 channels	7 channels	

2. Block Diagram

Figure 1. Block diagram of MB96(F)34x

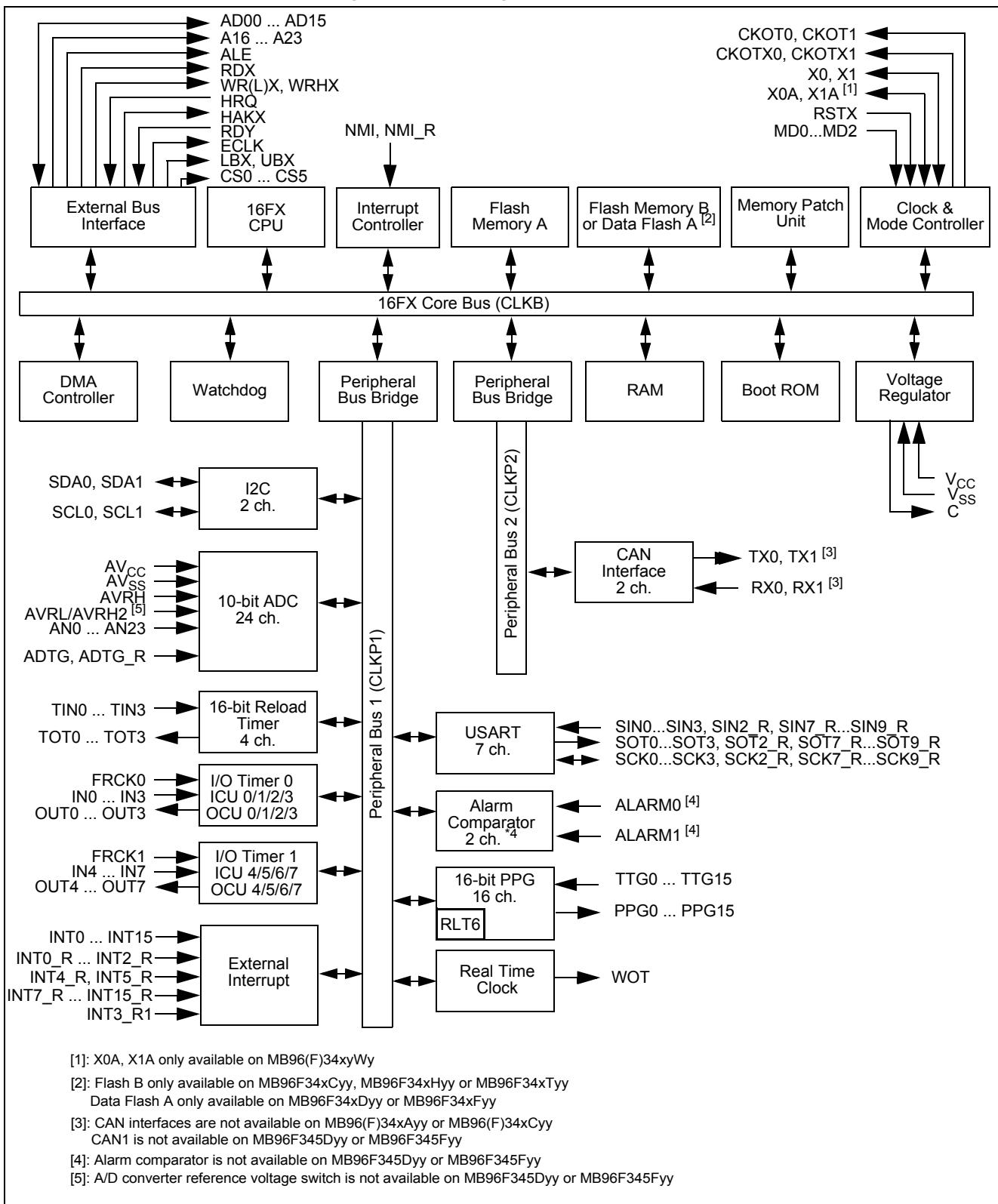
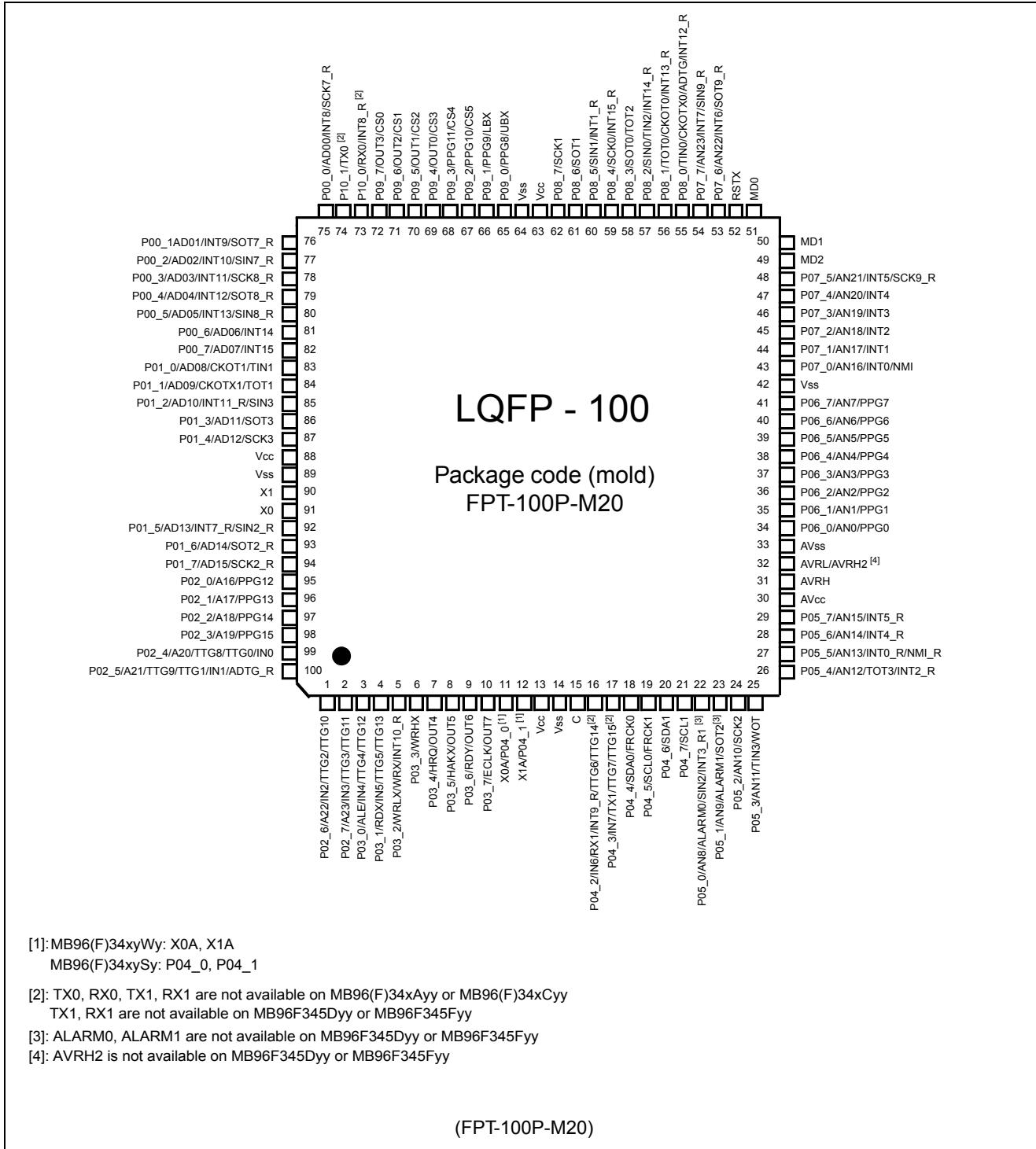
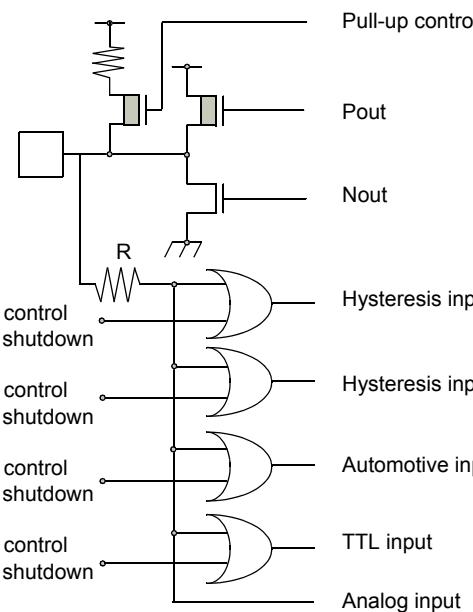
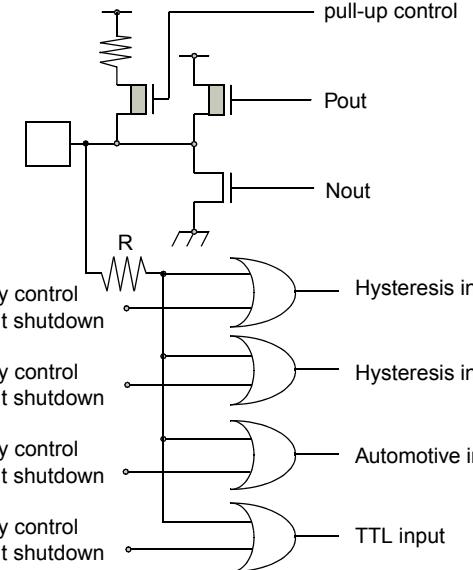


Figure 3. Pin assignment of MB96(F)34x (FPT-100P-M20)

Remark:

 MB96(F)34x products are pin-compatible to F²MC-16LX family MB90340 series.

Type	Circuit	Remarks
I	 <p>Pull-up control Pout Nout Hysteresis input Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Automotive input TTL input Analog input</p>	<ul style="list-style-type: none"> ■ CMOS level output (programmable $I_{OL} = 5\text{mA}$, $I_{OH} = -5\text{mA}$ and $I_{OL} = 2\text{mA}$, $I_{OH} = -2\text{mA}$) ■ 2 different CMOS hysteresis inputs with input shutdown function * ■ Automotive input with input shutdown function ■ TTL input with input shutdown function * ■ Programmable pull-up resistor: $50\text{k}\Omega$ approx. ■ Analog input <p>*MB96F345Dyy or MB96F345Fyy: Only Automotive input and CMOS hysteresis input (0.7/0.3) are supported</p>
N	 <p>pull-up control Pout Nout Hysteresis input Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Standby control for input shutdown Automotive input TTL input</p>	<ul style="list-style-type: none"> ■ CMOS level output ($I_{OL} = 3\text{mA}$, $I_{OH} = -3\text{mA}$) ■ 2 different CMOS hysteresis inputs with input shutdown function * ■ Automotive input with input shutdown function ■ TTL input with input shutdown function * ■ Programmable pull-up resistor: $50\text{k}\Omega$ approx. <p>*MB96F345Dyy or MB96F345Fyy: Only Automotive input and CMOS hysteresis input (0.7/0.3) are supported</p>

		MB96F348Y	MB96F348T
		MB96F348R	MB96F348H
		MB96F348A	MB96F348C
Alternative mode CPU address	Flash memory mode address	Flash size 544kByte	Flash size 576kByte
FF:FFFF _H	3F:FFFF _H	S39 - 64K	S39 - 64K
FF:0000 _H	3F:0000 _H		
FE:FFFF _H	3E:FFFF _H	S38 - 64K	S38 - 64K
FE:0000 _H	3E:0000 _H		
FD:FFFF _H	3D:FFFF _H	S37 - 64K	S37 - 64K
FD:0000 _H	3D:0000 _H		
FC:FFFF _H	3C:FFFF _H	S36 - 64K	S36 - 64K
FC:0000 _H	3C:0000 _H		
FB:FFFF _H	3B:FFFF _H	S35 - 64K	S35 - 64K
FB:0000 _H	3B:0000 _H		
FA:FFFF _H	3A:FFFF _H	S34 - 64K	S34 - 64K
FA:0000 _H	3A:0000 _H		
F9:FFFF _H	39:FFFF _H	S33 - 64K	S33 - 64K
F9:0000 _H	39:0000 _H		
F8:FFFF _H	38:FFFF _H	S32 - 64K	S32 - 64K
F8:0000 _H	38:0000 _H		
F7:FFFF _H	37:FFFF _H		
F7:0000 _H	37:0000 _H		
F6:FFFF _H	36:FFFF _H		
F6:0000 _H	36:0000 _H		
F5:FFFF _H	35:FFFF _H		
F5:0000 _H	35:0000 _H		
F4:FFFF _H	34:FFFF _H		
F4:0000 _H	34:0000 _H		
F3:FFFF _H	33:FFFF _H		
F3:0000 _H	33:0000 _H		
F2:FFFF _H	32:FFFF _H		
F2:0000 _H	32:0000 _H		
F1:FFFF _H	31:FFFF _H		
F1:0000 _H	31:0000 _H		
F0:FFFF _H	30:FFFF _H		
F0:0000 _H	30:0000 _H		
E0:FFFF _H			
E0:0000 _H			
DF:FFFF _H		Reserved	Reserved
DF:8000 _H			
DF:7FFF _H	1F:7FFF _H	SA3 - 8K	SA3 - 8K
DF:6000 _H	1F:6000 _H		
DF:5FFF _H	1F:5FFF _H	SA2 - 8K	SA2 - 8K
DF:4000 _H	1F:4000 _H		
DF:3FFF _H	1F:3FFF _H	SA1 - 8K	SA1 - 8K
DF:2000 _H	1F:2000 _H		
DF:1FFF _H	1F:1FFF _H	SA0 - 8K [1]	SA0 - 8K [1]
DF:0000 _H	1F:0000 _H		
DE:FFFF _H		Reserved	Reserved
DE:8000 _H			
DE:7FFF _H	1E:7FFF _H	SB3 - 8K	SB3 - 8K
DE:6000 _H	1E:6000 _H		
DE:5FFF _H	1E:5FFF _H	SB2 - 8K	SB2 - 8K
DE:4000 _H	1E:4000 _H		
DE:3FFF _H	1E:3FFF _H	SB1 - 8K	SB1 - 8K
DE:2000 _H	1E:2000 _H		
DE:1FFF _H	1E:1FFF _H	SB0 - 8K [2]	SB0 - 8K [2]
DE:0000 _H	1E:0000 _H		

[1]: Sector SA0 contains the ROM Configuration Block RCBA at CPU address DF:0000_H - DF:007F_H

[2]: Sector SB0 contains the ROM Configuration Block RCBB at CPU address DE:0000_H - DE:002F_H

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
00004B _H	ICU3 - Capture Register High	IPCPH3		R
00004C _H	ICU4/ICU5 - Control Status Register	ICS45		R/W
00004D _H	ICU4/ICU5 - Edge register	ICE45		R/W
00004E _H	ICU4 - Capture Register Low	IPCPL4	IPCP4	R
00004F _H	ICU4 - Capture Register High	IPCPH4		R
000050 _H	ICU5 - Capture Register Low	IPCPL5	IPCP5	R
000051 _H	ICU5 - Capture Register High	IPCPH5		R
000052 _H	ICU6/ICU7 - Control Status Register	ICS67		R/W
000053 _H	ICU6/ICU7 - Edge register	ICE67		R/W
000054 _H	ICU6 - Capture Register Low	IPCPL6	IPCP6	R
000055 _H	ICU6 - Capture Register High	IPCPH6		R
000056 _H	ICU7 - Capture Register Low	IPCPL7	IPCP7	R
000057 _H	ICU7 - Capture Register High	IPCPH7		R
000058 _H	EXTINT0 - External Interrupt Enable Register	ENIR0		R/W
000059 _H	EXTINT0 - External Interrupt Interrupt request Register	EIRR0		R/W
00005A _H	EXTINT0 - External Interrupt Level Select Low	ELVRL0	ELVR0	R/W
00005B _H	EXTINT0 - External Interrupt Level Select High	ELVRH0		R/W
00005C _H	EXTINT1 - External Interrupt Enable Register	ENIR1		R/W
00005D _H	EXTINT1 - External Interrupt Interrupt request Register	EIRR1		R/W
00005E _H	EXTINT1 - External Interrupt Level Select Low	ELVRL1	ELVR1	R/W
00005F _H	EXTINT1 - External Interrupt Level Select High	ELVRH1		R/W
000060 _H	RLT0 - Timer Control Status Register Low	TMCSRL0	TMCSR0	R/W
000061 _H	RLT0 - Timer Control Status Register High	TMCSRH0		R/W
000062 _H	RLT0 - Reload Register - for writing		TMRLR0	W
000062 _H	RLT0 - Reload Register - for reading		TMR0	R
000063 _H	RLT0 - Reload Register - for writing			W
000063 _H	RLT0 - Reload Register - for reading			R
000064 _H	RLT1 - Timer Control Status Register Low	TMCSRL1	TMCSR1	R/W
000065 _H	RLT1 - Timer Control Status Register High	TMCSRH1		R/W
000066 _H	RLT1 - Reload Register - for writing		TMRLR1	W
000066 _H	RLT1 - Reload Register - for reading		TMR1	R
000067 _H	RLT1 - Reload Register - for writing			W

Table 4: I/O map MB96(F)34x

Address	Register	Abbreviation 8-bit access	Abbreviation 16-bit access	Access
000081 _H	PPG1 - Timer register			R
000082 _H	PPG1 - Period setting register		PCSR1	W
000083 _H	PPG1 - Period setting register			W
000084 _H	PPG1 - Duty cycle register		PDUT1	W
000085 _H	PPG1 - Duty cycle register			W
000086 _H	PPG1 - Control status register Low	PCNL1	PCN1	R/W
000087 _H	PPG1 - Control status register High	PCNH1		R/W
000088 _H	PPG2 - Timer register		PTMR2	R
000089 _H	PPG2 - Timer register			R
00008A _H	PPG2 - Period setting register		PCSR2	W
00008B _H	PPG2 - Period setting register			W
00008C _H	PPG2 - Duty cycle register		PDUT2	W
00008D _H	PPG2 - Duty cycle register			W
00008E _H	PPG2 - Control status register Low	PCNL2	PCN2	R/W
00008F _H	PPG2 - Control status register High	PCNH2		R/W
000090 _H	PPG3 - Timer register		PTMR3	R
000091 _H	PPG3 - Timer register			R
000092 _H	PPG3 - Period setting register		PCSR3	W
000093 _H	PPG3 - Period setting register			W
000094 _H	PPG3 - Duty cycle register		PDUT3	W
000095 _H	PPG3 - Duty cycle register			W
000096 _H	PPG3 - Control status register Low	PCNL3	PCN3	R/W
000097 _H	PPG3 - Control status register High	PCNH3		R/W
000098 _H	PPG7-PPG4 - General Control register 1 Low	GCN1L1	GCN11	R/W
000099 _H	PPG7-PPG4 - General Control register 1 High	GCN1H1		R/W
00009A _H	PPG7-PPG4 - General Control register 2 Low	GCN2L1	GCN21	R/W
00009B _H	PPG7-PPG4 - General Control register 2 High	GCN2H1		R/W
00009C _H	PPG4 - Timer register		PTMR4	R
00009D _H	PPG4 - Timer register			R
00009E _H	PPG4 - Period setting register		PCSR4	W
00009F _H	PPG4 - Period setting register			W
0000A0 _H	PPG4 - Duty cycle register		PDUT4	W

Table 5: Interrupt vector table MB96(F)34x

Vector number	Offset in vector table	Vector name	Cleared by DMA	Index in ICR to program	Description
90	294 _H	LINT7	Yes	90	LIN USART 7 TX
91	290 _H	LINR8	Yes	91	LIN USART 8 RX
92	28C _H	LINT8	Yes	92	LIN USART 8 TX
93	288 _H	LINR9	Yes	93	LIN USART 9 RX
94	284 _H	LINT9	Yes	94	LIN USART 9 TX
95	280 _H	RTC0	No	95	Real Timer Clock
96	27C _H	CAL0	No	96	Clock Calibration Unit
97	278 _H	DFLASH_A	Yes	97	Data Flash A (only MB96F345Dyy, MB96F345Fyy)

13. Handling Devices

Special care is required for the following when handling the device:

- Latch-up prevention
- Unused pins handling
- External clock usage
- Unused sub clock signal
- Notes on PLL clock mode operation
- Power supply pins (V_{CC}/V_{SS})
- Crystal oscillator circuit
- Turn on sequence of power supply to A/D converter and analog inputs
- Pin handling when not using the A/D converter
- Notes on energization
- Stabilization of power supply voltage
- Serial communication
- Handling of Data Flash

13.1 Latch-up prevention

CMOS IC chips may suffer latch-up under the following conditions:

- A voltage higher than V_{CC} or lower than V_{SS} is applied to an input or output pin.
- A voltage higher than the rated voltage is applied between V_{CC} pins and V_{SS} pins.
- The AV_{CC} power supply is applied before the V_{CC} voltage.

Latch-up may increase the power supply current dramatically, causing thermal damages to the device.

For the same reason, extra care is required to not let the analog power-supply voltage ($AV_{CC}, AVRH$) exceed the digital power-supply voltage.

13.2 Unused pins handling

Unused input pins can be left open when the input is disabled (corresponding bit of Port Input Enable register PIER = 0).

Leaving unused input pins open when the input is enabled may result in misbehavior and possible permanent damage of the device. They must therefore be pulled up or pulled down through resistors. To prevent latch-up, those resistors should be more than 2 k Ω .

Unused bidirectional pins can be set either to the output state and be then left open, or to the input state with either input disabled or external pull-up/pull-down resistor as described above.

13.3 External clock usage

The permitted frequency range of an external clock depends on the oscillator type and configuration. See [AC Characteristics](#) for detailed modes and frequency limits. Single and opposite phase external clocks must be connected as follows:

Parameter	Symbol	Rating		Unit	Remarks
		Min	Max		
Permitted Power dissipation (Mask ROM devices) ^[4]	P _D	-	350	mW	T _A =105°C
		-	360	mW	T _A =125°C ^[6]
Operating ambient temperature	T _A	0	+70	°C	MB96V300B
		-40	+105		
		-40	+125		^[6]
Storage temperature	T _{STG}	-55	+150	°C	

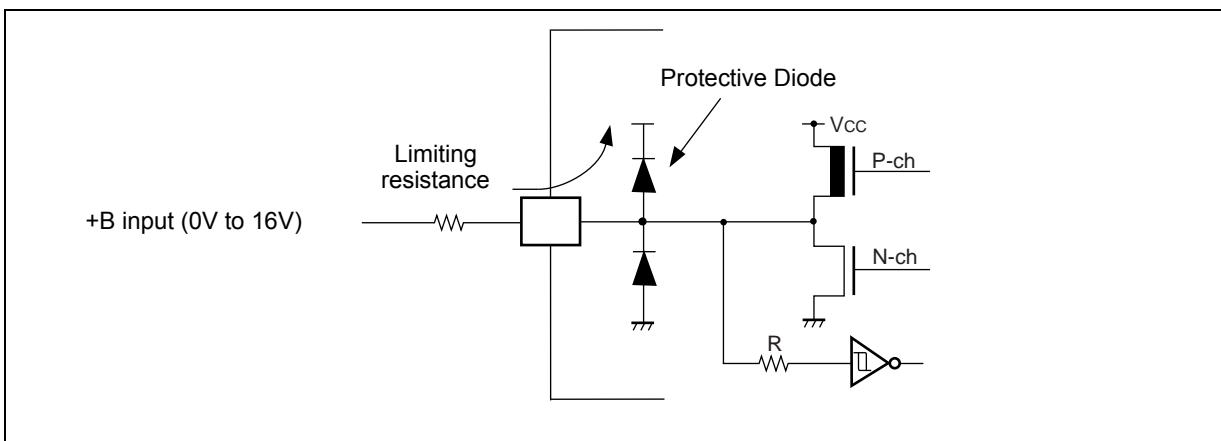
[1]: AV_{CC} and V_{CC} must be set to the same voltage. It is required that AV_{CC} does not exceed V_{CC} and that the voltage at the analog inputs does not exceed AV_{CC} neither when the power is switched on.

[2]: V_I and V_O should not exceed V_{CC} + 0.3 V. V_I should also not exceed the specified ratings. However if the maximum current to/from a input is limited by some means with external components, the I_{CLAMP} rating supersedes the V_I rating. Input/output voltages of standard ports depend on V_{CC}.

[3]:

- Applicable to all general purpose I/O pins (Pnn_m)
- Use within recommended operating conditions.
- Use at DC voltage (current)
- The +B signal should always be applied a limiting resistance placed between the +B signal and the microcontroller.
- The value of the limiting resistance should be set so that when the +B signal is applied the input current to the microcontroller pin does not exceed rated values, either instantaneously or for prolonged periods.
- Note that when the microcontroller drive current is low, such as in the power saving modes, the +B input potential may pass through the protective diode and increase the potential at the V_{CC} pin, and this may affect other devices.
- Note that if a +B signal is input when the microcontroller power supply is off (not fixed at 0 V), the power supply is provided from the pins, so that incomplete operation may result.
- Note that if the +B input is applied during power-on, the power supply is provided from the pins and the resulting supply voltage may not be sufficient to operate the Power reset (except devices with persistent low voltage reset in internal vector mode).

Sample recommended circuits:



[4]: The maximum permitted power dissipation depends on the ambient temperature, the air flow velocity and the thermal conductance of the package on the PCB. The actual power dissipation depends on the customer application and can be calculated as follows:

$$P_D = P_{IO} + P_{INT}$$

$P_{IO} = \sum (V_{OL} * I_{OL} + V_{OH} * I_{OH})$ (IO load power dissipation, sum is performed on all IO ports)

$P_{INT} = V_{CC} * (I_{CC} + I_A)$ (internal power dissipation)

I_{CC} is the total core current consumption into V_{CC} as described in the "DC characteristics" and depends on the selected operation mode and clock frequency and the usage of functions like Flash programming or the clock modulator. I_A is the analog current consumption into AV_{CC} .

[5]: Worst case value for a package mounted on single layer PCB at specified T_A without air flow.

[6]: Please contact Cypress for reliability limitations when using under these conditions.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed any of these ratings.

14.2 Recommended Operating Conditions

Parameter	Symbol	Value			Unit	Remarks
		Min	Typ	Max		
Power supply voltage	V_{CC}	3.0	-	5.5	V	
Smoothing capacitor at C pin	C_S	3.5	4.7 - 10	15	μF	Use a low inductance capacitor (for example X7R ceramic capacitor)

WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

14.3 DC characteristics

($T_A = -40^\circ\text{C}$ to 125°C , $V_{CC} = AV_{CC} = 3.0\text{V}$ to 5.5V , $V_{SS} = AV_{SS} = 0\text{V}$)

Parameter	Symbol	Pin	Condition	Value			Unit	Remarks
				Min	Typ	Max		
Input H voltage	V_{IH}	Port inputs P_{nn_m}	CMOS Hysteresis 0.8/0.2 input selected	0.8 V_{CC}	-	$V_{CC} + 0.3$	V	
			CMOS Hysteresis 0.7/0.3 input selected	0.7 V_{CC}	-	$V_{CC} + 0.3$	V	$V_{CC} \geq 4.5\text{V}$
			AUTOMOTIVE Hysteresis input selected	0.74 V_{CC}	-	$V_{CC} + 0.3$	V	$V_{CC} < 4.5\text{V}$
			TTL input selected	2.0	-	$V_{CC} + 0.3$	V	
	V_{IHX0F}	X0	External clock in "Fast Clock Input mode"	0.8 V_{CC}	-	$V_{CC} + 0.3$	V	Not available in MB96F34xY/R/AxA
	V_{IHX0S}	X0,X1, X0A,X1A	External clock in "oscillation mode"	2.5	-	$V_{CC} + 0.3$	V	
	V_{IHR}	RSTX	-	0.8 V_{CC}	-	$V_{CC} + 0.3$	V	CMOS Hysteresis input
Input L voltage	V_{IL}	Port inputs P_{nn_m}	CMOS Hysteresis 0.8/0.2 input selected	$V_{SS} - 0.3$	-	0.2 V_{CC}	V	
			CMOS Hysteresis 0.7/0.3 input selected	$V_{SS} - 0.3$	-	0.3 V_{CC}	V	
			AUTOMOTIVE Hysteresis input selected	$V_{SS} - 0.3$	-	0.5 V_{CC}	V	$V_{CC} \geq 4.5\text{V}$
			TTL input selected	$V_{SS} - 0.3$	-	0.46 V_{CC}		$V_{CC} < 4.5\text{V}$
			External clock in "Fast Clock Input mode"	$V_{SS} - 0.3$	-	0.8	V	
	V_{ILX0F}	X0	External clock in "oscillation mode"	$V_{SS} - 0.3$	-	0.2 V_{CC}	V	Not available in MB96F34xY/R/AxA
	V_{ILX0S}	X0,X1, X0A,X1A	-	$V_{SS} - 0.3$	-	0.4	V	
	V_{ILR}	RSTX	-	$V_{SS} - 0.3$	-	0.2 V_{CC}	V	CMOS Hysteresis input
Output H voltage	V_{OH2}	Normal outputs	$4.5\text{V} \leq V_{CC} \leq 5.5\text{V}$ $I_{OH} = -2\text{mA}$	$V_{CC} - 0.5$	-	-	V	Driving strength set to 2mA
			$3.0\text{V} \leq V_{CC} < 4.5\text{V}$ $I_{OH} = -1.6\text{mA}$		-	-		
	V_{OH5}	Normal outputs	$4.5\text{V} \leq V_{CC} \leq 5.5\text{V}$ $I_{OH} = -5\text{mA}$	$V_{CC} - 0.5$	-	-	V	Driving strength set to 5mA
			$3.0\text{V} \leq V_{CC} < 4.5\text{V}$ $I_{OH} = -3\text{mA}$		-	-		
	V_{OH3}	3mA outputs	$4.5\text{V} \leq V_{CC} \leq 5.5\text{V}$ $I_{OH} = -3\text{mA}$	$V_{CC} - 0.5$	-	-	V	
			$3.0\text{V} \leq V_{CC} < 4.5\text{V}$ $I_{OH} = -2\text{mA}$		-	-		

14.4.8 Bus Timing (Read)

($T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{CC} = 5.0 \text{ V} \pm 10\%$, $V_{SS} = 0.0 \text{ V}$, $\text{IO}_{\text{drive}} = 5\text{mA}$, $C_L = 50\text{pF}$)

Parameter	Symbol	Pin	Conditions	Value		Unit	Remarks
				Min	Max		
ALE pulse width	t_{LHLL}	ALE	EACL:STS=0 and EACL:ACE=0	$t_{CYC}/2 - 5$	-	ns	
			EACL:STS=1	$t_{CYC} - 5$	-		
			EACL:STS=0 and EACL:ACE=1	$3t_{CYC}/2 - 5$	-		
Valid address \Rightarrow ALE \downarrow time	t_{AVLL}	ALE, A[23:16],	EACL:STS=0 and EACL:ACE=0	$t_{CYC} - 15$	-	ns	
			EACL:STS=1 and EACL:ACE=0	$3t_{CYC}/2 - 15$	-		
			EACL:STS=0 and EACL:ACE=1	$2t_{CYC} - 15$	-		
			EACL:STS=1 and EACL:ACE=1	$5t_{CYC}/2 - 15$	-		
	t_{ADVLL}	ALE,AD[15:0]	EACL:STS=0 and EACL:ACE=0	$t_{CYC}/2 - 15$	-	ns	
			EACL:STS=1 and EACL:ACE=0	$t_{CYC} - 15$	-		
			EACL:STS=0 and EACL:ACE=1	$3t_{CYC}/2 - 15$	-		
			EACL:STS=1 and EACL:ACE=1	$2t_{CYC} - 15$	-		
ALE \downarrow \Rightarrow Address valid time	t_{LLAX}	ALE, AD[15:0]	EACL:STS=0	$t_{CYC}/2 - 15$	-	ns	
			EACL:STS=1	-15	-		
Valid address \Rightarrow RDX \downarrow time	t_{AVRL}	RDX, A[23:16]	EACL:ACE=0	$3t_{CYC}/2 - 15$	-	ns	
			EACL:ACE=1	$5t_{CYC}/2 - 15$	-		
	t_{ADVRL}	RDX, AD[15:0]	EACL:ACE=0	$t_{CYC} - 15$	-	ns	
			EACL:ACE=1	$2t_{CYC} - 15$	-		
Valid address \Rightarrow Valid data input	t_{AVDV}	A[23:16], AD[15:0]	EACL:ACE=0	-	$3t_{CYC} - 55$	ns	w/o cycle extension
			EACL:ACE=1	-	$4t_{CYC} - 55$		
	$t_{ADV DV}$	AD[15:0]	EACL:ACE=0	-	$5t_{CYC}/2 - 55$	ns	w/o cycle extension
			EACL:ACE=1	-	$7t_{CYC}/2 - 55$		
RDX pulse width	t_{RLRH}	RDX	-	$3t_{CYC}/2 - 5$	-	ns	w/o cycle extension
RDX \downarrow \Rightarrow Valid data input	t_{RLDV}	RDX, AD[15:0]	-	-	$3t_{CYC}/2 - 50$	ns	w/o cycle extension
RDX \uparrow \Rightarrow Data hold time	t_{RHDX}	RDX, AD[15:0]	-	0	-	ns	
Address valid \Rightarrow Data hold time	t_{AXDX}	A[23:16], AD[15:0]	-	0	-	ns	

14.4.9 Bus Timing (Write)

($T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{CC} = 5.0 \text{ V} \pm 10\%$, $V_{SS} = 0.0 \text{ V}$, $\text{IO}_{\text{drive}} = 5\text{mA}$, $C_L = 50\text{pF}$)

Parameter	Symbol	Pin	Condition	Value		Unit	Remarks
				Min	Max		
Valid address \Rightarrow WRX \downarrow time	t _{AVWL}	WRX, WRLX, WRHX, A[23:16]	EACL:ACE=0	$3t_{CYC}/2 - 15$	-	ns	
			EACL:ACE=1	$5t_{CYC}/2 - 15$	-		
	t _{ADVWL}	WRX, WRLX, WRHX, AD[15:0]	EACL:ACE=0	$t_{CYC} - 15$	-	ns	
			EACL:ACE=1	$2t_{CYC} - 15$	-		
WRX pulse width	t _{WLWH}	WRX, WRXL, WRHX	-	$t_{CYC} - 5$	-	ns	w/o cycle extension
Valid data output \Rightarrow WRX \uparrow time	t _{DVWH}	WRX, WRLX, WRHX, AD[15:0]	-	$t_{CYC} - 20$	-	ns	w/o cycle extension
WRX \uparrow \Rightarrow Data hold time	t _{WHDX}	WRX, WRLX, WRHX, AD[15:0]	-	$t_{CYC}/2 - 15$	-	ns	
WRX \uparrow \Rightarrow Address valid time	t _{WHAX}	WRX, WRLX, WRHX, A[23:16]	-	$t_{CYC}/2 - 15$	-	ns	
WRX \uparrow \Rightarrow ALE \uparrow time	t _{WHLH}	WRX, WRLX, WRHX, ALE	EBM:ACE=1 and EACL:STS=1	$2t_{CYC} - 10$	-	ns	
			other EBM:ACE and EACL:STS setting	$t_{CYC} - 10$	-		
WRX \downarrow \Rightarrow ECLK \uparrow time	t _{WLCH}	WRX, WRLX, WRHX, ECLK	-	$t_{CYC}/2 - 10$	-	ns	
CSn \Rightarrow WRX time	t _{CSLWL}	WRX, WRLX, WRHX, CSn	EACL:ACE=0	-	$3t_{CYC}/2 - 15$	ns	
			EACL:ACE=1	-	$5t_{CYC}/2 - 15$		
WRX \Rightarrow CSn time	t _{WHCSH}	WRX, WRLX, WRHX, CSn	-	$t_{CYC}/2 - 15$	-	ns	

($T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{CC} = 3.0$ to 4.5V , $V_{SS} = 0.0 \text{ V}$, $\text{IO}_{\text{drive}} = 5\text{mA}$, $C_L = 50\text{pF}$)

Parameter	Symbol	Pin	Condition	Value		Unit	Remarks
				Min	Max		
Valid address \Rightarrow WRX \downarrow time	t _{AVWL}	WRX, WRLX, WRHX, A[23:16]	EACL:ACE=0	$3t_{CYC}/2 - 20$	-	ns	
			EACL:ACE=1	$5t_{CYC}/2 - 20$	-		
	t _{ADVWL}	WRX, WRLX, WRHX, AD[15:0]	EACL:ACE=0	$t_{CYC} - 20$	-	ns	
			EACL:ACE=1	$2t_{CYC} - 20$	-		

($T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{CC} = 3.0$ to 4.5V , $V_{SS} = 0.0 \text{ V}$, $IO_{drive} = 5\text{mA}$, $C_L = 50\text{pF}$)

Parameter	Symbol	Pin	Condition	Value		Unit	Remarks
				Min	Max		
WRX pulse width	t_{WLWH}	WRX, WRXL, WRHX	-	$t_{CYC} - 8$	-	ns	w/o cycle extension
Valid data output \Rightarrow WRX \uparrow time	t_{DVWH}	WRX, WRLX, WRHX, AD[15:0]	-	$t_{CYC} - 25$	-	ns	w/o cycle extension
WRX \uparrow \Rightarrow Data hold time	t_{WHDX}	WRX, WRLX, WRHX, AD[15:0]	-	$t_{CYC}/2 - 20$	-	ns	
WRX \uparrow \Rightarrow Address valid time	t_{WHAX}	WRX, WRLX, WRHX, A[23:16]	-	$t_{CYC}/2 - 20$	-	ns	
WRX \uparrow \Rightarrow ALE \uparrow time	t_{WHLH}	WRX, WRLX, WRHX, ALE	EBM:ACE=1 and EACL:STS=1	$2t_{CYC} - 15$	-	ns	
			other EBM:ACE and EACL:STS setting	$t_{CYC} - 15$	-		
WRX \downarrow \Rightarrow ECLK \uparrow time	t_{WLCH}	WRX, WRLX, WRHX, ECLK	-	$t_{CYC}/2 - 15$	-	ns	
CSn \Rightarrow WRX time	t_{CSLWL}	WRX, WRLX, WRHX, CSn	EACL:ACE=0	-	$3t_{CYC}/2 - 20$	ns	
			EACL:ACE=1	-	$5t_{CYC}/2 - 20$		
WRX \Rightarrow CSn time	t_{WHCSH}	WRX, WRLX, WRHX, CSn	-	$t_{CYC}/2 - 20$	-	ns	

14.4.12 USART timing

WARNING: The values given below are for an I/O driving strength $IO_{drive} = 5mA$. If IO_{drive} is $2mA$, all the maximum output timing described in the different tables must then be increased by 10ns.

($T_A = -40^\circ C$ to $125^\circ C$, $V_{CC} = 3.0V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $IO_{drive} = 5mA$, $C_L = 50pF$)

Parameter	Symbol	Pin	Condition	$V_{CC} = AV_{CC} = 4.5V$ to $5.5V$		$V_{CC} = AV_{CC} = 3.0V$ to $4.5V$		Unit
				Min	Max	Min	Max	
Serial clock cycle time	t_{SCYCI}	SCKn	Internal Shift Clock Mode	$4 t_{CLKP1}$	-	$4 t_{CLKP1}$	-	ns
SCK \downarrow SOT delay time	t_{SLOVI}	SCKn, SOTn		-20	+20	-30	+30	ns
SOT \rightarrow SCK \uparrow delay time	t_{OVSHI}	SCKn, SOTn		$N*t_{CLKP1} - 20$ [1]	-	$N*t_{CLKP1} - 30$ [1]	-	ns
Valid SIN \rightarrow SCK \uparrow	t_{IVSHI}	SCKn, SINn		$t_{CLKP1} + 45$	-	$t_{CLKP1} + 55$	-	ns
SCK \uparrow \rightarrow Valid SIN hold time	t_{SHIXI}	SCKn, SINn		0	-	0	-	ns
Serial clock "L" pulse width	t_{SLSHE}	SCKn	External Shift Clock Mode	$t_{CLKP1} + 10$	-	$t_{CLKP1} + 10$	-	ns
Serial clock "H" pulse width	t_{SHSLE}	SCKn		$t_{CLKP1} + 10$	-	$t_{CLKP1} + 10$	-	ns
SCK \downarrow SOT delay time	t_{SLOVE}	SCKn, SOTn		-	$2 t_{CLKP1} + 45$	-	$2 t_{CLKP1} + 55$	ns
Valid SIN \rightarrow SCK \uparrow	t_{IVSHE}	SCKn, SINn		$t_{CLKP1}/2 + 10$	-	$t_{CLKP1}/2 + 10$	-	ns
SCK \uparrow \rightarrow Valid SIN hold time	t_{SHIXE}	SCKn, SINn		$t_{CLKP1} + 10$	-	$t_{CLKP1} + 10$	-	ns
SCK fall time	t_{FE}	SCKn		-	20	-	20	ns
SCK rise time	t_{RE}	SCKn		-	20	-	20	ns

Notes:

- AC characteristic in CLK synchronized mode.
- C_L is the load capacity value of pins when testing.
- Depending on the used machine clock frequency, the maximum possible baud rate can be limited by some parameters. These parameters are shown in "MB96300 Super series HARDWARE MANUAL".
- t_{CLKP1} is the cycle time of the peripheral clock 1 (CLKP1), Unit : ns

[1]: Parameter N depends on t_{SCYCI} and can be calculated as follows:

- if $t_{SCYCI} = 2*k*t_{CLKP1}$, then $N = k$, where k is an integer > 2
- if $t_{SCYCI} = (2*k+1)*t_{CLKP1}$, then $N = k+1$, where k is an integer > 1

Examples:

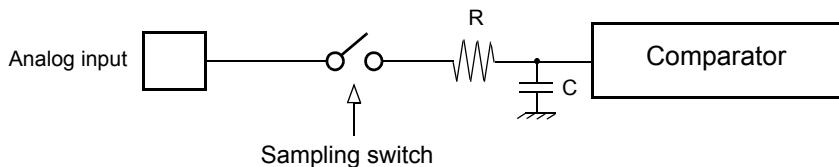
t_{SCYCI}	N
$4*t_{CLKP1}$	2
$5*t_{CLKP1}$,	3
$7*t_{CLKP1}$,	4
...	...

14.5.2 Notes on A/D Converter Section

- About the external impedance of the analog input and the sampling time of the A/D converter (with sample and hold circuit):

If the external impedance is too high to keep sufficient sampling time, the analog voltage charged to the internal sample and hold capacitor is insufficient, adversely affecting A/D conversion precision.

Analog input circuit model:



Reference value:

$C = 8.5 \text{ pF} (\text{Max})$

To satisfy the A/D conversion precision standard, the relationship between the external impedance and minimum sampling time must be considered and then either the resistor value and operating frequency must be adjusted or the external impedance must be decreased so that the sampling time (T_{samp}) is longer than the minimum value. Usually, this value is set to 7τ , where $\tau = RC$. If the external input resistance (R_{ext}) connected to the analog input is included, the sampling time is expressed as follows:

$$T_{\text{samp}} [\text{min}] = 7 \times (R_{\text{ext}} + 2.6\text{k}\Omega) \times C \text{ for } 4.5 \leq AV_{\text{cc}} \leq 5.5$$

$$T_{\text{samp}} [\text{min}] = 7 \times (R_{\text{ext}} + 12.1\text{k}\Omega) \times C \text{ for } 3.0 \leq AV_{\text{cc}} \leq 4.5$$

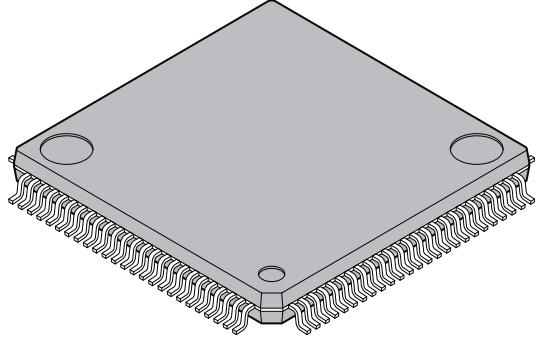
If the sampling time cannot be sufficient, connect a capacitor of about $0.1 \mu\text{F}$ to the analog input pin.

- About the error

The accuracy gets worse as $|AV_{\text{RH}} - AV_{\text{RL}}|$ becomes smaller.

16. Package Dimension MB96(F)34x LQFP 100P

100-pin plastic LQFP
(FPT-100P-M20)



Lead pitch	0.50 mm
Package width × package length	14.0 mm × 14.0 mm
Lead shape	Gullwing
Sealing method	Plastic mold
Mounting height	1.70 mm Max
Weight	0.65 g
Code (Reference)	P-LFQFP100-14×14-0.50

